

**Search Notes**

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Thien D. Tran

Applicant(s)/Patent under  
Reexamination

KRONESTEDT ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See interference search		12/1/2006	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT). See search printout	12/1/2006	TT